

UNISONIC TECHNOLOGIES CO., LTD

9N65K-MT

Preliminary

9A, 650V N-CHANNEL POWER MOSFET

DESCRIPTION

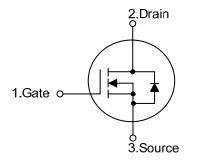
The UTC **9N65K-MT** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC **9N65K-MT** is generally applied in high efficiency switch mode power supplies and uninterruptible power supplies.

FEATURES

- * $R_{DS(ON)}$ < 1.1 Ω @ V_{GS} = 10 V, , I_{D} = 5.1 A
- * High Switching Speed
- * Improved dv/dt Capability
- * 100% Avalanche Tested

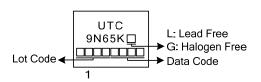
SYMBOL

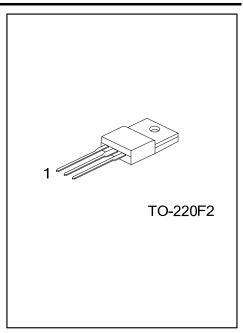


ORDERING INFORMATION

Ordering	Deekege	Pin Assignment			Deaking			
Lead Free Halogen Free		Package	1	2	3	Packing		
9N65K-L-TF2-T	9N65K-G-TF2-T	TO-220F2	G	D	S	Tube		
Note: Pin Assignment: G: Gate D: Drain S: Source								
9N65KL-TF2-T	(1) T: Tube (2) TF2: TO-220F2 (3) L: Lead Free, G: Halogen Free and Lead Free							

MARKING





ABSOLUTE MAXIMUM RATINGS (TJ=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	650	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Drain Current	Continuous, @)T _C =25°C		9	А
	V _{GSS} @10V @)T _c =100°C	l _D	5.4	А
	Pulsed (Note 2)		I _{DM}	36	А
Avalanche Energy	valanche Energy Repetitive (Note 3)		E _{AS}	375	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	2.8	V/ns	
Power Dissipation		D	49	W	
Derate above 25°C		P _D	0.39	W/°C	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive rating; pulse width limited by max. junction temperature.

3. L=9.25mH, I_{AS} =9A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

4. I_{SD}≤5.2A, di/dt≤90A/µs, V_{DD}≤BV_{DSS}, T_J≤150°C

5. Drain current limited by maximum junction temperature

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ」	2.54	°C/W	



■ ELECTRICAL CHARACTERISTICS (TJ=25°C, unless otherwise specified)

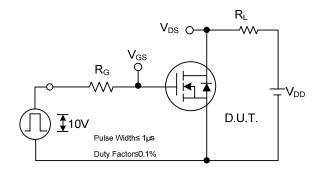
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μΑ, V _{GS} =0V	650			V
Breakdown Voltage Temperature Coefficient	$\Delta \ {\sf BV}_{\sf DSS}$ / $\Delta {\sf T}_{\sf J}$	Reference to 25°C, I _D =1mA		0.67		V/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} =650V, V _{GS} =0V			25	μA
		V _{DS} =520V, V _{GS} =0V, T _J =125°C			250	
Gate- Source Leakage Current	- I _{GSS}	V _{GS} =+30V			+100	nA
Reverse		V _{GS} =-30V			-100	nA
ON CHARACTERISTICS	r	1				
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} = V _{GS} , I _D =250µA	2.0		4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =5.1A			1.1	Ω
DYNAMIC PARAMETERS						
Input Capacitance	C _{ISS}			870		рF
Output Capacitance	C _{oss}	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		122		pF
Reverse Transfer Capacitance	C _{RSS}			10		pF
SWITCHING PARAMETERS						
Turn-ON Delay Time	t _{D(ON)}			65		ns
Rise Time	t _R	V _{DD} =30V, I _D =0.5A, R _G =25Ω,		80		ns
Turn-OFF Delay Time	t _{D(OFF)}	R _D = 62Ω (Note 1, 2)		160		ns
Fall-Time	t _F			84		ns
Total Gate Charge	Q _G			29.8		nC
Gate to Source Charge	Q _{GS}	V _{DS} =50V, V _{GS} =10V, I _D =1.3A		8.6		nC
Gate to Drain ("Miller") Charge	Q_{GD}	(Note 1, 2)		7.3		nC
SOURCE- DRAIN DIODE RATINGS AND	CHARACTER	ISTICS				
Maximum Body-Diode Continuous Current	ls				9	Α
Maximum Body-Diode Pulsed Current	I _{SM}				20	٨
(Note 1)					36	A
Drain-Source Diode Forward Voltage	V _{SD}	T _J =25°C, I _S =9A,V _{GS} =0V(Note 2)			1.5	V

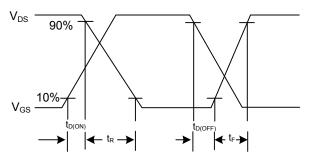
Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



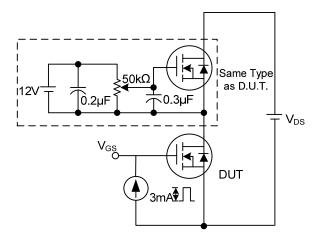
TEST CIRCUITS AND WAVEFORMS



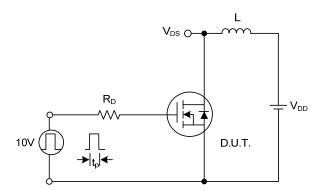


Switching Test Circuit

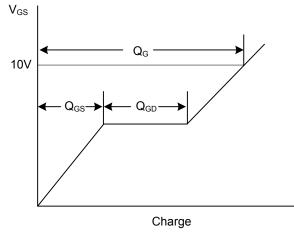




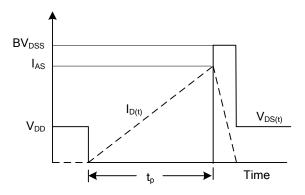
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit







Unclamped Inductive Switching Waveforms



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